

Picoamp Input Current, Microvolt Offset, Low Noise Op Amp

FEATURES

Guaranteed Bias Current

 $T_A = 25^{\circ}C: 100pA Max$

 $T_A = -55^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} : 600\text{pA Max}$

■ Guaranteed Offset Voltage: 120µV Max

■ Guaranteed Drift: 1.5µV/°C Max

■ Low Noise, 0.1Hz to 10Hz: 0.5μV_{P-P}

■ Guaranteed Low Supply Current: 600µA Max

Guaranteed CMRR: 114dB Min

Guaranteed PSRR: 114dB Min

Guaranteed Voltage Gain with 5mA Load Current

Available in 8-Lead PDIP and SO Packages

APPLICATIONS

- Precision Instrumentation
- Charge Integrators
- Wide Dynamic Range Logarithmic Amplifiers
- Light Meters
- Low Frequency Active Filters
- Standard Cell Buffers
- Thermocouple Amplifiers

DESCRIPTION

The LT®1008 is a universal precision operational amplifier that can be used in practically all precision applications. The LT1008 combines for the first time, picoampere bias currents (which are maintained over the full –55°C to 125°C temperature range), microvolt offset voltage (and low drift with time and temperature), low voltage and current noise, and low power dissipation. Extremely high common mode and power supply rejection ratios, and the ability to deliver 5mA load current with high voltage gain round out the LT1008's superb precision specifications.

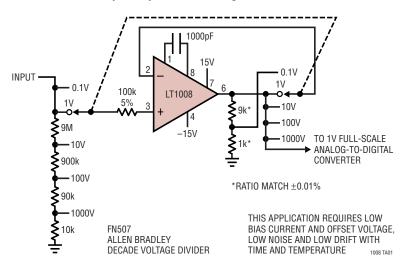
The all around excellence of the LT1008 eliminates the necessity of the time consuming error analysis procedure of precision system design in many applications; the LT1008 can be stocked as the universal precision op amp.

The LT1008 is externally compensated with a single capacitor for additional flexibility in shaping the frequency response of the amplifier. It plugs into and upgrades all standard LM108A/LM308A applications. For an internally compensated version with even lower offset voltage but otherwise similar performance see the LT1012.

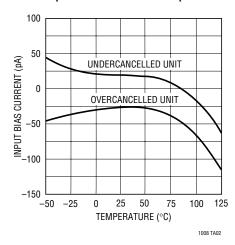
17. LT. LTC and LTM are registered trademarks of Linear Technology Corporation.

TYPICAL APPLICATION

Input Amplifier for 4.5 Digit Voltmeter



Input Bias Current vs Temperature

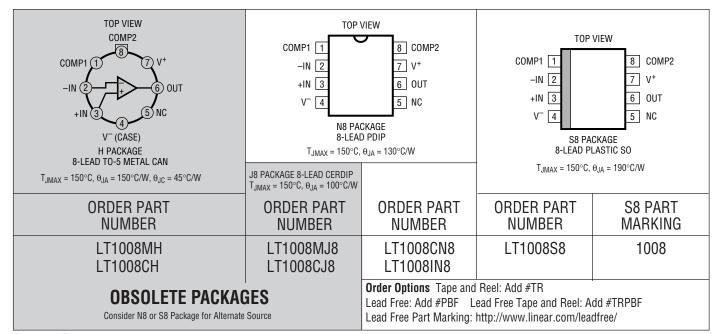


ABSOLUTE MAXIMUM RATINGS (Note 1)

Supply Voltage	±20V
Differential Input Current (Note 2)	±10mA
Input Voltage	±20V
Output Short-Circuit Duration	Indefinite
Storage Temperature Range	. −65°C to 150°C

Operating Temperature Range	
LT1008M (OBSOLETE)	55°C to 125°C
LT1008C	0°C to 70°C
LT1008I	40°C to 85°C
Lead Temperature (Soldering, 10 se	c)300°C

PACKAGE/ORDER INFORMATION



Consult LTC Marketing for parts specified with wider operating temperature ranges.

ELECTRICAL CHARACTERISTICS $V_S = \pm 15 V, \ V_{CM} = 0 V, \ T_A = 25 ^{\circ} C, \ unless \ otherwise \ noted.$

			L	T1008I	•	1	_T1008	-	
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
V_{OS}	Input Offset Voltage			30	120		30	120	μV
		(Note 3)		40	180		40	180	μV
	Long-Term Input Offset Voltage Stability			0.3			0.3		μV/Month
I _{OS}	Input Offset Current			30	100		30	100	pA
		(Note 3)		40	150		40	150	pA
I _B	Input Bias Current			±30	±100		±30	±100	pA
		(Note 3)		±40	±150		±40	±150	pA
e _n	Input Noise Voltage	0.1Hz to 10Hz		0.5			0.5		μV _{P-P}
	Input Noise Voltage Density	f ₀ = 10Hz (Note 4)		17	30		17	30	nV√Hz
		f ₀ = 1000Hz (Note 5)		14	22		14	22	nV/√Hz
i _n	Input Noise Current Density	f ₀ = 10Hz		20			20		fA/√Hz
A _{VOL}	Large-Signal Voltage Gain	$V_{OUT} = \pm 12V, R_L \ge 10k$	200	2000		200	2000		V/mV
- '		$V_{OUT} = \pm 10V, R_L \ge 2k$	120	600		120	600		V/mV

LINEAR TECHNOLOGY

ELECTRICAL CHARACTERISTICS $V_S = \pm 15 V, \ V_{CM} = 0 V, \ T_A = 25 ^{\circ} C, \ unless \ otherwise \ noted.$

				LT	1008N	1/I	L	T1008	С	
SYMBOL	PARAMETER	CONDITIONS	M	IIN	TYP	MAX	MIN	TYP	MAX	UNITS
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 13.5V$	1	14	132		114	132		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 2V \text{ to } \pm 20V$	1	14	132		114	132		dB
	Input Voltage Range		±1	3.5	±14		±13.5	±14		V
V _{OUT}	Output Voltage Swing	R _L = 10k	±	13	±14		±13	±14		V
	Slew Rate	C _F = 30pF	0	1.1	0.2		0.1	0.2		V/µs
I _S	Supply Current	(Note 3)			380	600		380	600	μА

The ullet indicates specifications which apply over the full operating temperature range of $-55^{\circ}C \le T_A \le 125^{\circ}C$ for the LT1008M, $-40^{\circ}C \le T_A \le 85^{\circ}C$ for the LT1008I and $0^{\circ}C \le T_A \le 70^{\circ}C$ for the LT1008C. $V_S = \pm 15V$, $V_{CM} = 0V$, unless otherwise noted.

				L.	Γ1008Ν	1/I	L	T1008	С	
SYMBOL	PARAMETER	CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNITS
V _{OS}	Input Offset Voltage	(Note 3)	•		50 60	250 320		40 50	180 250	μV μV
	Average Temperature Coefficient of Input Offset Voltage		•		0.2	1.5		0.2	1.5	μV/°C
I _{OS}	Input Offset Current	(Note 3)	•		60 80	250 350		40 50	180 250	pA pA
	Average Temperature Coefficient of Input Offset Current		•		0.4	2.5		0.4	2.5	pA/°C
I _B	Input Bias Current	(Note 3)	•		±80 ±150	±600 ±800		±40 ±50	±180 ±250	pA pA
	Average Temperature Coefficient of Input Bias Current		•		0.6	6		0.4	2.5	pA/°C
A _{VOL}	Large-Signal Voltage Gain	$V_{OUT} = \pm 12V, R_L \ge 10k$	•	100	1000		150	1500		V/mV
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 13.5V$	•	108	128		110	130		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 2.5 V \text{ to } \pm 20 V$	•	108	126		110	128		dB
	Input Voltage Range		•	±13.5			±13.5			V
V _{OUT}	Output Voltage Swing	R _L = 10k	•	±13	±14		±13	±14		V
I _S	Supply Current		•		400	800		400	800	μА

(LT1008S8 only) V_S = $\pm 15 V,~V_{CM}$ = 0V, T_A = 25°C, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V _{OS}	Input Offset Voltage			30	200	μV
		(Note 3)		40	250	μV
	Long-Term Input Offset Voltage Stability			0.3		μV/Month
I _{OS}	Input Offset Current			100	280	pA
		(Note 3)		120	380	pA
I _B	Input Bias Current			±100	±300	pA
		(Note 3)		±120	±400	pA
e _n	Input Noise Voltage	0.1Hz to 10Hz		0.5		μV _{P-P}
	Input Noise Voltage Density	f ₀ = 10Hz (Note 5)		17	30	nV/√Hz
		$f_0 = 1000 Hz \text{ (Note 5)}$		14	22	nV/√Hz

ELECTRICAL CHARACTERISTICS (LT1008S8 only) $V_S = \pm 15V$, $V_{CM} = 0V$, $T_A = 25$ °C, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
i _n	Input Noise Current Density	f ₀ = 10Hz		20		fA/√Hz
A _{VOL}	Large-Signal Voltage Gain	$V_{OUT} = \pm 12V$, $R_L \ge 10k$ $V_{OUT} = \pm 10V$, $R_L \ge 2k$	200 120	2000 600		V/mV V/mV
CMRR	Common Mode Rejection Ratio	V _{CM} = ±13.5V	110	132		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 2V \text{ to } \pm 20V$	110	132		dB
	Input Voltage Range		±13.5	±14		V
V _{OUT}	Output Voltage Swing	R _L = 10k	±13	±14		V
	Slew Rate	C _F = 30pF	0.1	0.2		V/µs
I _S	Supply Current	(Note 3)		380	600	μА

(LT1008S8 only) The ullet indicates specifications which apply over the full operating temperature range of 0°C \leq T_A \leq 70°C. $V_S = \pm 15V$, $V_{CM} = 0V$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
V _{OS}	Input Offset Voltage	(Note 3)	•		40 50	280 340	μV μV
	Average Temperature Coefficient of Input Offset Voltage		•		0.2	1.8	μV/°C
I _{OS}	Input Offset Current	(Note 3)	•		120 140	380 500	pA pA
	Average Temperature Coefficient of Input Offset Current		•		0.4	4	pA/°C
I _B	Input Bias Current	(Note 3)	•		±120 ±140	±420 ±550	pA pA
	Average Temperature Coefficient of Input Bias Current		•		0.4	5	pA/°C
A _{VOL}	Large-Signal Voltage Gain	$V_{OUT} = \pm 12V, R_L \ge 10k$	•	150	1500		V/mV
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 13.5V$	•	108	130		dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 2.5 V \text{ to } \pm 20 V$	•	108	128		dB
	Input Voltage Range		•	±13.5			V
V _{OUT}	Output Voltage Swing	R _L = 10k	•	±13	±14		V
Is	Supply Current		•		400	800	μА

Note 1:Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: Differential input voltages greater than 1V will cause excessive current to flow through the input protection diodes unless current limiting resistors are used.

Note 3: These specifications apply for $\pm 2V \le V_S \le \pm 20V$ ($\pm 2.5V \le V_S \le \pm 20V$ over the temperature range) and $-13.5V \le V_{CM} \le 13.5V$ (for $V_S = \pm 15V$).

Note 4: 10Hz noise voltage density is sample tested on every lot. Devices 100% tested at 10Hz are available on request.

Note 5: This parameter is tested on a sample basis only.

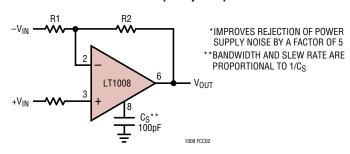
LINEAR TECHNOLOGY

FREQUENCY COMPENSATION CIRCUITS

Standard Compensation Circuit

$-V_{IN} \xrightarrow{R1} R2$ $-V_{IN} \xrightarrow{R3} 3$ $+V_{IN} \xrightarrow{R3} 3$ $+V_{IN} \xrightarrow{R3} 3$ $+V_{IN} \xrightarrow{R1} R2$ $-**BANDWIDTH AND SLEW RATE ARE PROPORTIONAL TO <math>1/C_F$ V_{OUT} $C_F \ge \frac{R1C_0}{R1 + R2}$ $C_0 = 30pF$

Alternate* Frequency Compensation

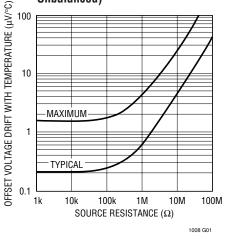


FOR $\frac{R2}{R1}$ > 200, NO EXTERNAL FREQUENCY COMPENSATION IS NECESSARY

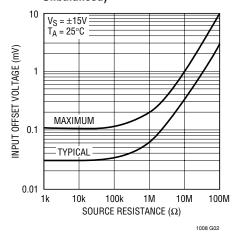
TYPICAL PERFORMANCE CHARACTERISTICS

1008 FCC01

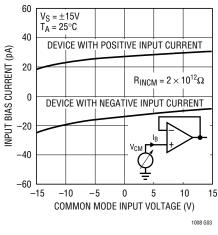




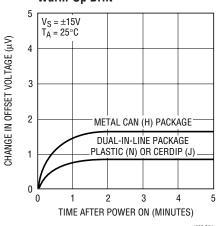
Offset Voltage vs Source Resistance (Balanced or Unbalanced)



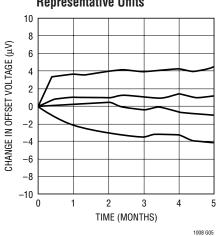
Input Bias Current vs Common Mode Range



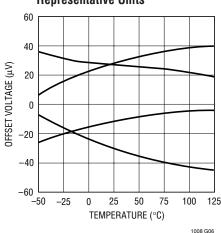
Warm-Up Drift



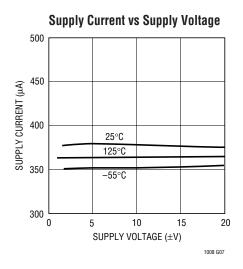
Long-Term Stability of Four Representative Units

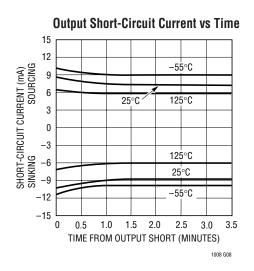


Offset Voltage Drift with Temperature of Four Representative Units

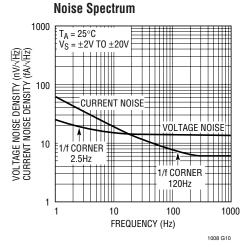


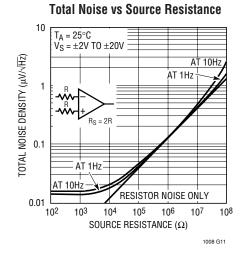
TYPICAL PERFORMANCE CHARACTERISTICS

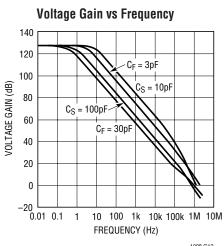


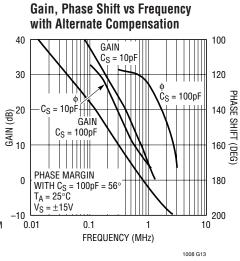


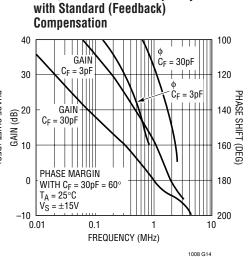
0.1Hz to 10Hz Noise $T_A = 25^{\circ}\text{C}$ $V_S = \pm 2 \text{V TO} \pm 20 \text{V}$ 0 2 4 6 8 10 TIME (SECONDS)











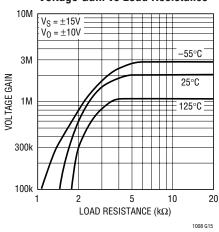
Gain, Phase Shift vs Frequency



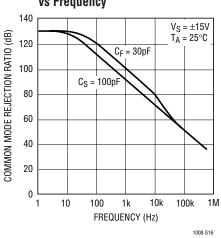


TYPICAL PERFORMANCE CHARACTERISTICS

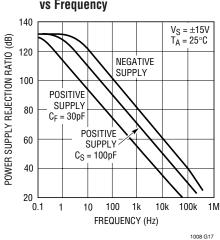
Voltage Gain vs Load Resistance



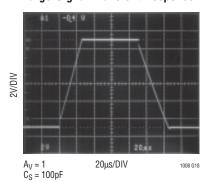
Common Mode Rejection vs Frequency



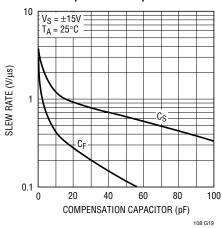
Power Supply Rejection vs Frequency



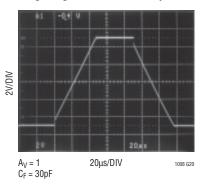
Large-Signal Transient Response



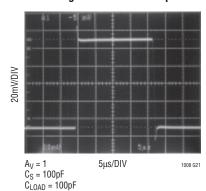
Slew Rate vs Compensation Capacitance



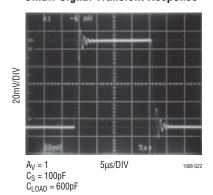
Large-Signal Transient Response



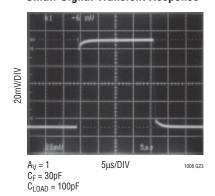
Small-Signal Transient Response



Small-Signal Transient Response



Small-Signal Transient Response

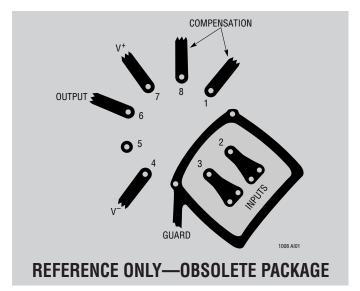


APPLICATIONS INFORMATION

Achieving Picoampere/Microvolt Performance

In order to realize the picoampere—microvolt level accuracy of the LT1008, proper care must be exercised. For example, leakage currents in circuitry external to the op amp can significantly degrade performance. High quality insulation should be used (e.g., TeflonTM, Kel-F); cleaning of all insulating surfaces to remove fluxes and other residues will probably be required. Surface coating may be necessary to provide a moisture barrier in high humidity environments.

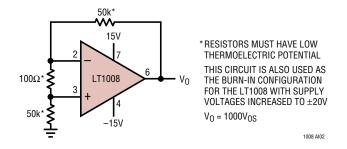
Board leakage can be minimized by encircling the input circuitry with a guard ring operated at a potential close to that of the inputs: in inverting configurations the guard ring should be tied to ground, in noninverting connections to the inverting input at Pin 2. Guarding both sides of the printed circuit board is required. Bulk leakage reduction depends on the guard ring width. Nanoampere level leakage into the compensation terminals can affect offset voltage and drift with temperature.



Microvolt level error voltages can also be generated in the external circuitry. Thermocouple effects caused by temperature gradients across dissimilar metals at the contacts to the input terminals can exceed the inherent drift of the amplifier. Air currents over device leads should be minimized, package leads should be short, and the two input leads should be as close together as possible and maintained at the same temperature.

The LT1008 is specified over a wide range of power supply voltages from $\pm 2V$ to $\pm 18V$. Operation with lower supplies is possible down to $\pm 1.2V$ (two Ni-Cad batteries).

Test Circuit for Offset Voltage and Its Drift with Temperature



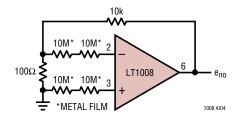
Noise Testing

The 0.1Hz to 10Hz peak-to-peak noise of the LT1008 is measured in the test circuit shown. The frequency response of this noise tester indicates that the 0.1Hz corner is defined by only one zero. The test time to measure 0.1Hz to 10Hz noise should not exceed 10 seconds, as this time limit acts as an additional zero to eliminate noise contributions from the frequency band below 0.1Hz.

A noise voltage density test is recommended when measuring noise on a large number of units. A 10Hz noise voltage density measurement will correlate well with a 0.1Hz to 10Hz peak-to-peak noise reading since both results are determined by the white noise and the location of the 1/f corner frequency.

Current noise is measured in the circuit shown and calculated by the following formula where the noise of the source resistors is subtracted.

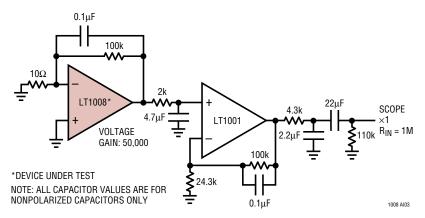
$$i_n = \frac{\left[e^2_{n0} - (820nV)^2\right]^{1/2}}{40MO \times 100}$$





APPLICATIONS INFORMATION

0.1Hz to 10Hz Noise Test Circuit



Frequency Compensation

The LT1008 is externally frequency compensated with a single capacitor. The two standard compensation circuits shown earlier are identical to the LM108A/LM308A frequency compensation schemes. Therefore, the LT1008 operational amplifiers can be inserted directly into LM108A/LM308A sockets, with similar AC and upgraded DC performance.

External frequency compensation provides the user with additional flexibility in shaping the frequency response of the amplifier. For example, for a voltage gain of ten and $C_F = 3pF$, a gain bandwidth product of 5MHz and slew rate of 1.2V/ μ s can be realized. For closed-loop gains in excess of 200, no external compensation is necessary, and slew rate increases to 4V/ μ s. The LT1008 can also be overcompensated (i.e., $C_F > 30pF$ or $C_S > 100pF$) to improve capacitive load handling capability or to narrow noise bandwidth. In many applications, the feedback loop around the amplifier has gain (e.g., logarithmic amplifiers); overcompensation can stabilize these circuits with a single capacitor.

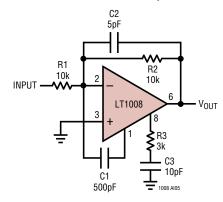
The availability of the compensation terminals permits the use of feedforward frequency compensation to enhance slew rate in low closed-loop gain configurations. The inverter slew rate is increased to $1.4V/\mu s$. The voltage follower feedforward scheme bypasses the amplifier's gain stages and slews at nearly $10V/\mu s$.

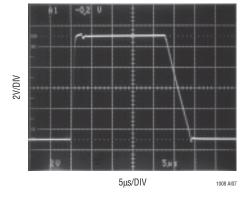
The inputs of the LT1008 are protected with back-to-back diodes. Current limiting resistors are not used, because the leakage of these resistors would prevent the realization of picoampere level bias currents at elevated temperatures.

In the voltage follower configuration, when the input is driven by a fast, large-signal pulse (>1V), the input protection diodes effectively short the output to the input during slewing, and a current, limited only by the output short-circuit protection, will flow through the diodes.

The use of a feedback resistor, as shown in the voltage follower feedforward diagram, is recommended because this resistor keeps the current below the short-circuit limit, resulting in faster recovery and settling of the output.

Inverter Feedforward Compensation



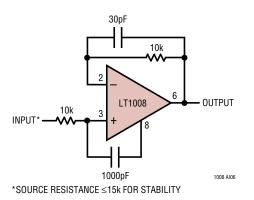


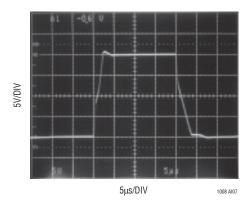
1008fl



APPLICATIONS INFORMATION

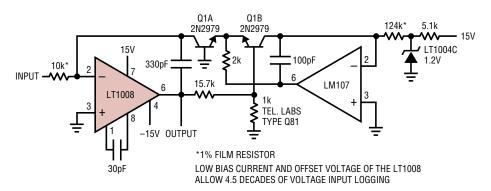
Follower Feedforward Compensation



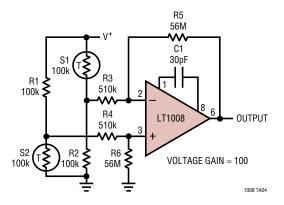


TYPICAL APPLICATIONS

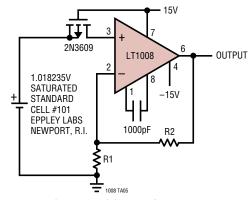
Logarithmic Amplifier



Amplifier for Bridge Transducers



Saturated Standard Cell Amplifier



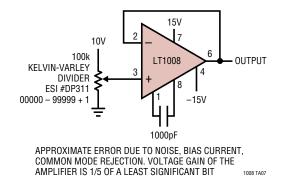
THE TYPICAL 30pA BIAS CURRENT OF THE LT1008 WILL DEGRADE THE STANDARD CELL BY ONLY 1ppm/YEAR. NOISE IS A FRACTION OF A ppm. UNPROTECTED GATE MOSFET ISOLATES STANDARD CELL ON POWER DOWN



TYPICAL APPLICATIONS

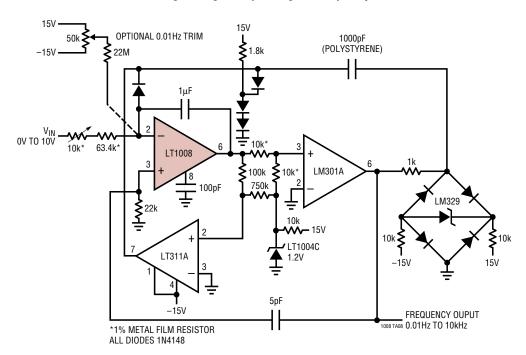
Amplifier for Photodiode Sensor

Five Decade Kelvin-Varley Divider Buffered by the LT1008



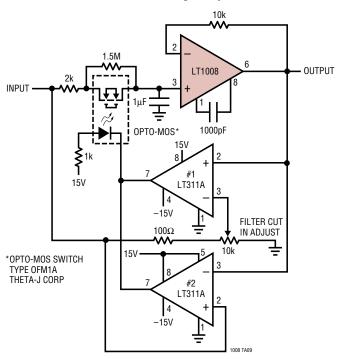
The LT1008 integrator extends low frequency range. Total dynamic range is 0.01Hz to 10kHz (or 120dB) with 0.01% linearity.

Extended Range Charge Pump Voltage to Frequency Converter



TYPICAL APPLICATIONS

Precision, Fast Settling, Lowpass Filter

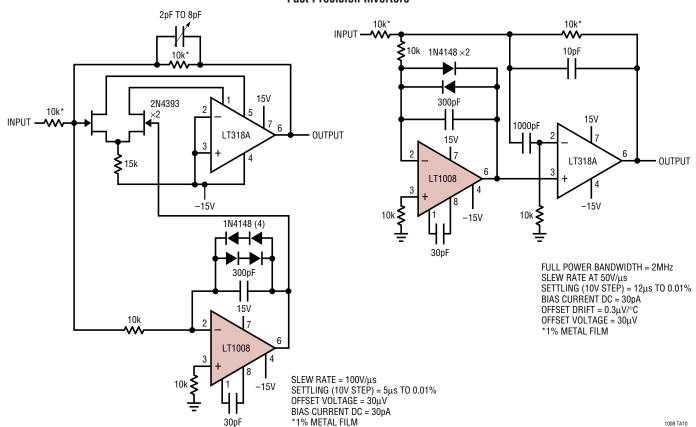


This circuit is useful where fast signal acquisition and high precision are required, as in electronic scales.

The filter's time constant is set by the 2k resistor and the $1\mu F$ capacitor until comparator 1 switches. The time constant is then set by the 1.5M resistor and the $1\mu F$ capacitor. Comparator 2 provides a quick reset.

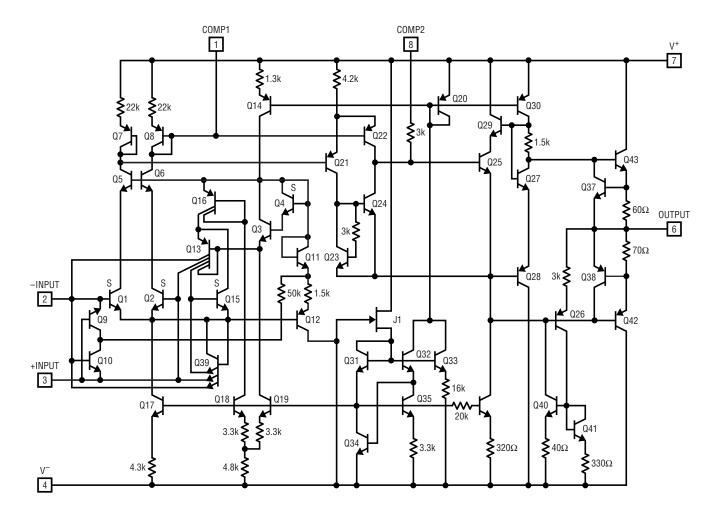
The circuit settles to a final value three times as fast as a simple $1.5M-1\mu F$ filter with almost no DC error.

Fast Precision Inverters

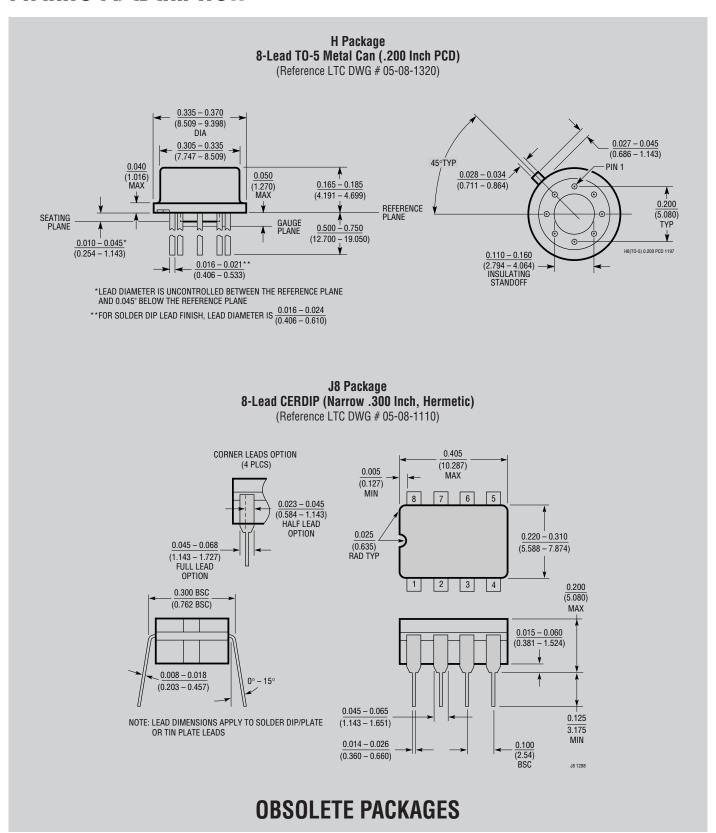


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SCHEMATIC DIAGRAM



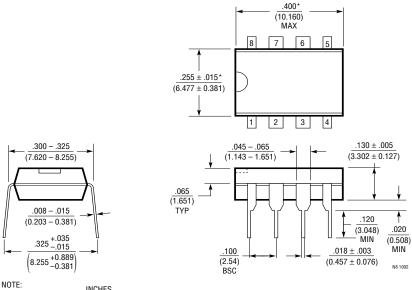
PACKAGE DESCRIPTION



PACKAGE DESCRIPTION

N8 Package 8-Lead PDIP (Narrow .300 Inch)

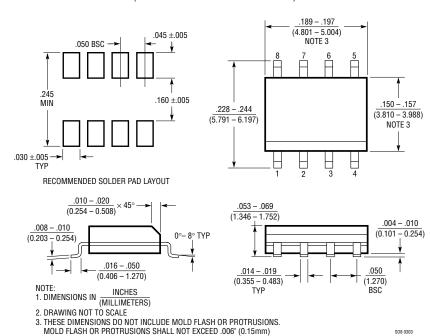
(Reference LTC DWG # 05-08-1510)



1. DIMENSIONS ARE MILLIMETERS

\$8 Package 8-Lead Plastic Small Outline (Narrow .150 Inch)

(Reference LTC DWG # 05-08-1610)



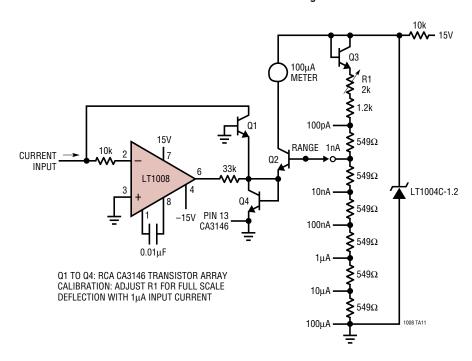
^{*}THESE DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.
MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED .010 INCH (0.254mm)

TYPICAL APPLICATION

Ammeter measures currents from 100pA to $100\mu A$ without the use of expensive high value resistors. Accuracy at

 $100\mu A$ is limited by the offset voltage between Q1 and Q2 and at 100pA by the inverting bias current of the LT1008.

Ammeter with Six Decade Range



RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS
LT1012	Picoamp Input Current, Microvolt Offset, Low Noise Op Amp	Internally Compensated LT1008
LT1112	Dual Low Power, Precision, Picoamp Input Op Amp	Dual LT1012
LT1880	SOT-23, Rail-to-Rail Output, Picoamp Input Current Precision Op Amp	Single SOT-23 Version of LT1884
LT1881/LT1882	Dual and Quad Rail-to-Rail Output, Picoamp Input Precision Op Amps	Dual/Quad C _{LOAD} Stable
LT1884/LT1885	Dual and Quad Rail-to-Rail Output, Picoamp Input Precision Op Amps	Dual/Quad Faster LT1881/LT1882